



# LIST OF REFERENCES CITED BY APPLICANT

Atty Docket No. 4925-112  
Serial No.: 09/916,001  
Applicant: Miikka HUOMO et al.

Filing Date: July 26, 2001  
Group Art:

## U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
	AD						
	AE						

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## FOREIGN PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Country	Name	Class	Subclass	Translation Yes/No
<del>70</del>	AF	07217213	03/07/97	Japan	Toda	H04M	3/5	Yes
	AG							
	AH							
	AI							
	AJ							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

	AK		
	AL		
	AM		

EXAMINER: **ELISEO RAMOS-FELICIANO**  
PATENT EXAMINER

DATE CONSIDERED: 4-30-04

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Atty Docket No.: 4925-112

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Serial No.: 09/916,001

Group Art: 2681

Applicant: Miikka HUOMO et al.

### U.S. PATENT DOCUMENTS

*Ex. Intls.		Document No.	Date	Name	Class	Subclass	Filing Date
	AA	6,192,245	02/2001	Jones et al.	455	437	07/1995
	AB	6,044,249	03/2000	Chandra et al.	455	62	11/1996
	AC	6,445,917	09/2002	Bark et al.	455	423	05/1999
	AD						
	AE						

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